


<b>Search Notes</b> 	<b>Application/Control No.</b> 10534186	<b>Applicant(s)/Patent Under Reexamination</b> LEIJON ET AL.
	<b>Examiner</b> Tamai, Karl	<b>Art Unit</b> 2834

SEARCHED			
Class	Subclass	Date	Examiner
310	74, 83, 179, 180, 208	07/06/2007	07/06/2007
310	74, 83, 179, 180, 208, 266, 268, 113	20080402	kit
322	4	20080402	kit
	update search	8/18/2008	kit

SEARCH NOTES		
Search Notes	Date	Examiner
310	07/06/207	Dustin Jacobs

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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